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Is Now



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Power MOSFET Dual N-Channel

3.1 Amps, 20 Volts

Features

- Low R_{DS(on)} for Higher Efficiency
- Logic Level Gate Drive
- Miniature ChipFET™ Surface Mount Package Saves Board Space

Applications

• Power Management in Portable and Battery-Powered Products; i.e., Cellular and Cordless Telephones and PCMCIA Cards

MAXIMUM RATINGS ($T_A = 25^{\circ}C$ unless otherwise noted)

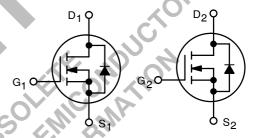
Rating	Symbol	5 secs	Steady State	Unit
Drain-Source Voltage	V_{DS}	2	0	V
Gate-Source Voltage	V _{GS}	±	12	V
Continuous Drain Current $(T_J = 150^{\circ}C)$ (Note 1) $T_A = 25^{\circ}C$ $T_A = 85^{\circ}C$	ID	±4.2 ±3.0	±3.1 ±2.2	A
Pulsed Drain Current	I _{DM}	±	10	A
Continuous Source Current (Diode Conduction) (Note 1)	ls	1.8	0.9	A
Maximum Power Dissipation (Note 1) T _A = 25°C T _A = 85°C	P _D	2.1 1.1	1.1 0.6	W
Operating Junction and Storage Temperature Range	T _J , T _{stg}	-55 to	+150	°C
1. Surface Mounted on 1" x 1" FR4 I	- 4/	PRE		



ON Semiconductor®

http://onsemi.com

DUAL N-CHANNEL 3.1 AMPS, 20 VOLTS $R_{DS(on)} = 75 \text{ m}\Omega$



Channel MOSFET

N-Channel MOSFET



ChipFET CASE 1206A STYLE 2

MARKING PIN CONNECTIONS DIAGRAM D₁ 8 D₁ 2 G₁ 2 [7 ⋋ D_2 3 S_2 3 6 D_2 4 G_2 5

A1 = Specific Device Code

ORDERING INFORMATION

Device	Package	Shipping
NTHD5904T1	ChipFET	3000/Tape & Reel

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THERMAL CHARACTERISTICS

Characteristic	Symbol	Тур	Max	Unit
Maximum Junction-to-Ambient (Note 2) t ≤ 5 sec Steady State	R _{thJA}	50 90	60 110	°C/W
Maximum Junction-to-Foot (Drain) Steady State	R _{thJF}	30	40	°C/W

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise noted)

Characteristic	Symbol	Test Condition	Min	Тур	Max	Unit
Static						•
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.6	-	-	V
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = 16 V, V _{GS} = 0 V	_	-	1.0	μΑ
		$V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V},$ $T_{J} = 85^{\circ}\text{C}$	-	-	5.0	
On-State Drain Current (Note 3)	I _{D(on)}	$V_{DS} \ge 5.0 \text{ V}, V_{GS} = 4.5 \text{ V}$	10	- / () -	Α
Drain-Source On-State Resistance (Note 3)	r _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 3.1 \text{ A}$	-	0.065	0.075	Ω
		$V_{GS} = 2.5 \text{ V}, I_D = 2.3 \text{ A}$	-	0.115	0.143	
Forward Transconductance (Note 3)	9 _{fs}	V _{DS} = 10 V, I _D = 3.1 A	-1	8.0	_	S
Diode Forward Voltage (Note 3)	V _{SD}	$I_S = 0.9 \text{ A}, V_{GS} = 0 \text{ V}$.O,	0.8	1.2	V
Dynamic (Note 4)		0° 41	7 . 1	>		
Total Gate Charge	Qg	025 (1)	Q-	4.0	6.0	nC
Gate-Source Charge	Q _{gs}	$V_{DS} = 10 \text{ V}, V_{GS} = 4.5 \text{ V},$ $I_{D} = 3.1 \text{ A}$) <u>-</u>	0.6	-	
Gate-Drain Charge	Q_{gd}	16, 40, 21	_	1.3	-	
Turn-On Delay Time	t _{d(on)}	-(1 A A	-	12	18	ns
Rise Time	t _r	$V_{DD} = 10 \text{ V}, R_{L} = 10 \Omega$	-	35	55	
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 1.0 \text{ A, } V_{GEN} = 4.5 \text{ V,}$ $R_G = 6 \Omega$	-	19	30	
Fall Time	tf	K 7 1/2	-	9.0	15	
Source-Drain Reverse Recovery Time	St _{rr}	I _F = 0.9 A, di/dt = 100 A/μs	-	40	80	

- Source–Drain Reverse Recovery Time t_{rr}

 2. Surface Mounted on 1" x 1" FR4 Board.
 3. Pulse Test: Pulse Width ≤ 300 µs, Duty Cycle ≤ 2%.
 4. Guaranteed by design, not subject to production testing.

TYPICAL ELECTRICAL CHARACTERISTICS

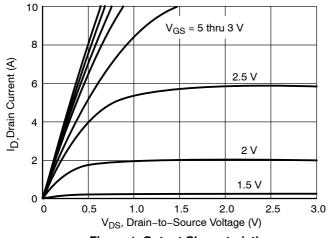


Figure 1. Output Characteristics

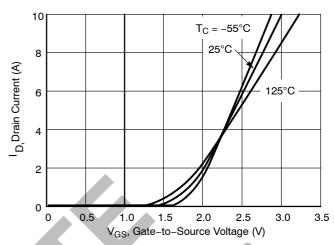


Figure 2. Transfer Characteristics

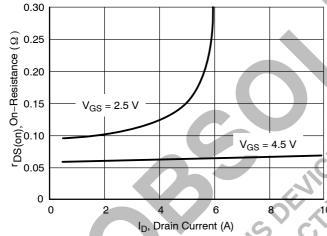


Figure 3. On–Resistance vs. Drain Current

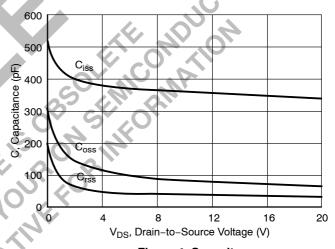
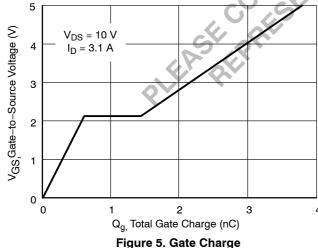


Figure 4. Capacitance





TYPICAL ELECTRICAL CHARACTERISTICS

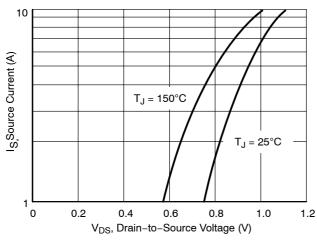


Figure 7. Source-Drain Diode Forward Voltage

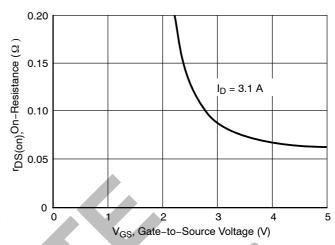


Figure 8. On-Resistance vs. Gate-to-Source Voltage

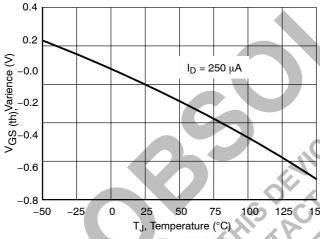


Figure 9. Threshold Voltage

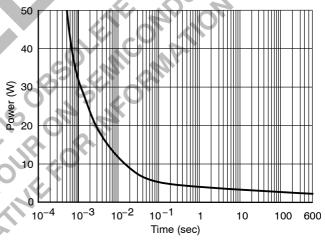


Figure 10. Single Pulse Power

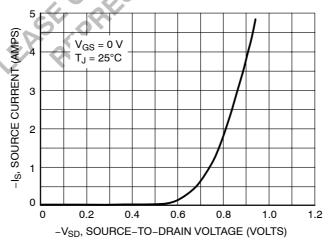


Figure 11. Diode Forward Voltage vs. Current

TYPICAL ELECTRICAL CHARACTERISTICS

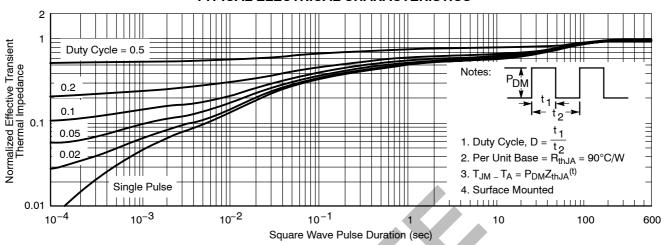


Figure 12. Normalized Thermal Transient Impedance, Junction-to-Ambient

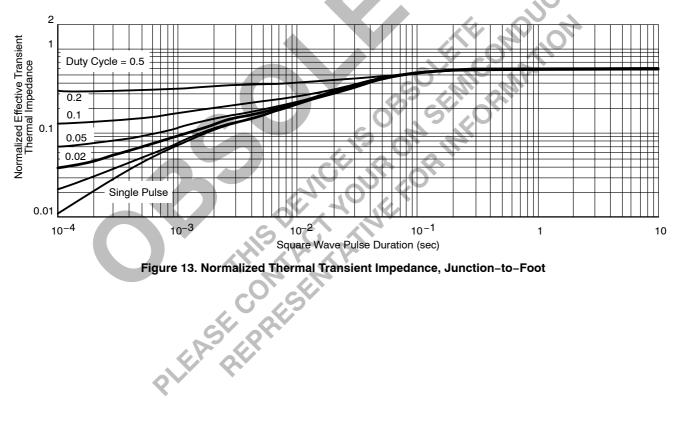


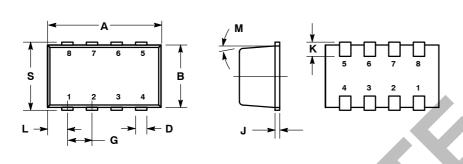
Figure 13. Normalized Thermal Transient Impedance, Junction-to-Foot

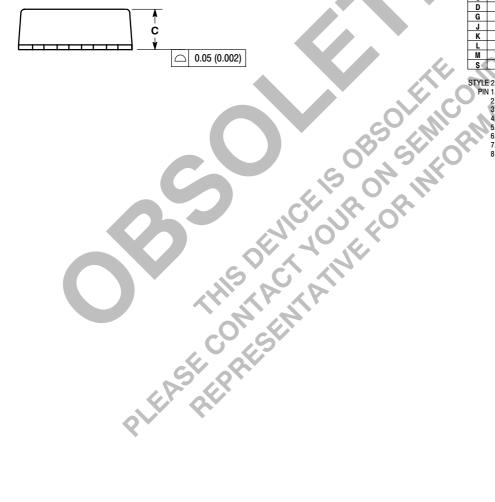
Notes



PACKAGE DIMENSIONS

ChipFET CASE 1206A-03 **ISSUE C**





NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI
- Y14.5M, 1982.
 2. CONTROLLING DIMENSION: MILLIMETER.
- MOLD GATE BURRS SHALL NOT EXCEED 0.13 MM PER SIDE
- LEADFRAME TO MOLDED BODY OFFSET IN HORIZONTAL AND VERTICAL SHALL NOT EXCEED
- 5. DIMENSIONS A AND B EXCLUSIVE OF MOLD GATE BURRS.
- NO MOLD FLASH ALLOWED ON THE TOP AND BOTTOM LEAD SURFACE.
- 1206A-01 AND 1206A-02 OBSOLETE. NEW STANDARD IS 1206A-03.

	MILLIMETERS		INCHES		
DIM	MIN	MAX	MIN	MAX	
Α	2.95	3.10	0.116	0.122	
В	1.55	1.70	0.061	0.067	
С	1.00	1.10	0.039	0.043	
D	0.25	0.35	0.010	0.014	
G	0.65 BSC		0.025 BSC		
J	0.10	0.20	0.004	0.008	
K	0.28	0.42	0.011	0.017	
L	0.55 BSC		0.022 BSC		
M	5 °	NOM 👞	5 ° NOM		
S	1.80	2.00	0.072	0.080	

- STYLE 2: PIN 1. 1. SOURCE 2. GATE 1 3. SOURCE 4. GATE 2

 - 5. DRAIN 1 6. DRAIN 1 7. DRAIN 2 8. DRAIN 2



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